



# **FQD1N50 / FQU1N50**

### 500V N-Channel MOSFET

#### **General Description**

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switch mode power supply, power factor correction, electronic lamp ballast based on half bridge.

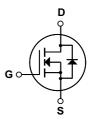
#### **Features**

- 1.1A, 500V,  $R_{DS(on)}$  = 9.0 $\Omega$  @V<sub>GS</sub> = 10 V Low gate charge ( typical 4.0 nC)
- Low Crss (typical 3.0 pF)
- · Fast switching
- · 100% avalanche tested
- Improved dv/dt capability
- · RoHS Compliant









## **Absolute Maximum Ratings** $T_C = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter		FQD1N50 / FQU1N50	Units
V <sub>DSS</sub>	Drain-Source Voltage		500	V
I <sub>D</sub>	Drain Current - Continuous (T <sub>C</sub> = 25°C)		1.1	Α
	- Continuous (T <sub>C</sub> = 100°C)		0.7	Α
I <sub>DM</sub>	Drain Current - Pulsed	(Note 1)	4.4	Α
V <sub>GSS</sub>	Gate-Source Voltage		± 30	V
E <sub>AS</sub>	Single Pulsed Avalanche Energy	(Note 2)	80	mJ
I <sub>AR</sub>	Avalanche Current	(Note 1)	1.1	Α
E <sub>AR</sub>	Repetitive Avalanche Energy	(Note 1)	2.5	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	4.5	V/ns
P <sub>D</sub>	Power Dissipation (T <sub>A</sub> = 25°C) *		2.5	W
	Power Dissipation (T <sub>C</sub> = 25°C) - Derate above 25°C		25	W
			0.2	W/°C
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature Range		-55 to +150	°C
T <sub>L</sub>	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	°C

### **Thermal Characteristics**

Symbol	Parameter	Тур	Max	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case		5.0	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient *		50	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient		110	°C/W

<sup>\*</sup> When mounted on the minimum pad size recommended (PCB Mount)

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Cha	aracteristics					
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 μA		500			V
ΔBV <sub>DSS</sub> / ΔT <sub>J</sub>	Breakdown Voltage Temperature Coefficient	I <sub>D</sub> = 250 μA, Referenced to 25°C		0.5		V/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 500 V, V <sub>GS</sub> = 0 V			1	μА
		V <sub>DS</sub> = 400 V, T <sub>C</sub> = 125°C			10	μА
I <sub>GSSF</sub>	Gate-Body Leakage Current, Forward	V <sub>GS</sub> = 30 V, V <sub>DS</sub> = 0 V			100	nA
I <sub>GSSR</sub>	Gate-Body Leakage Current, Reverse	V <sub>GS</sub> = -30 V, V <sub>DS</sub> = 0 V			-100	nA
On Cha	racteristics		•			
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$	3.0		5.0	V
R <sub>DS(on)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> =10 V, I <sub>D</sub> =0.55 A		6.8	9.0	Ω
9 <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> = 50 V, I <sub>D</sub> = 0.55 A (Note 4)		0.98		S
C <sub>oss</sub> C <sub>rss</sub>	Output Capacitance Reverse Transfer Capacitance	f = 1.0 MHz		3.0	30 4.0	pF pF
C <sub>rss</sub>	Reverse Transfer Capacitance			3.0	4.0	pF
Switchi	ing Characteristics					
	ing Characteristics Turn-On Delay Time	Vpp = 250 V lp = 1.4 A		5	20	ns
t <sub>d(on)</sub>		$V_{DD} = 250 \text{ V, } I_{D} = 1.4 \text{ A,}$ $R_{G} = 25 \Omega$		5 25	20	ns ns
t <sub>d(on)</sub>	Turn-On Delay Time	$R_G = 25 \Omega$				
$t_{d(on)}$ $t_r$ $t_{d(off)}$	Turn-On Delay Time Turn-On Rise Time	55		25	60	ns
$t_{d(on)}$ $t_r$ $t_{d(off)}$ $t_f$ $Q_g$	Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time	$R_G = 25 \Omega$		25 8	60 25	ns ns
$t_{d(on)}$ $t_r$ $t_{d(off)}$ $t_f$ $Q_g$	Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time	$R_G = 25 \Omega$ (Note 4, 5) $V_{DS} = 400 \text{ V}, I_D = 1.4 \text{ A}, V_{GS} = 10 \text{ V}$		25 8 20	60 25 50	ns ns ns
$t_{d(on)}$ $t_r$ $t_{d(off)}$ $t_f$ $Q_g$ $Q_{gs}$	Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge	$R_G = 25 \Omega$ (Note 4, 5) $V_{DS} = 400 \text{ V}, I_D = 1.4 \text{ A},$		25 8 20 4.0	60 25 50 5.5	ns ns ns
$t_{d(on)}$ $t_r$ $t_{d(off)}$ $t_f$ $Q_g$ $Q_{gs}$ $Q_{gd}$	Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge	$R_{G}$ = 25 $\Omega$ (Note 4, 5) $V_{DS}$ = 400 V, $I_{D}$ = 1.4 A, $V_{GS}$ = 10 V (Note 4, 5)		25 8 20 4.0 1.1	60 25 50 5.5 	ns ns ns nC
$egin{array}{l} t_{d(on)} & & & & & & & & & & & & & & & & & & &$	Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge Gate-Drain Charge	$R_{G} = 25~\Omega \label{eq:RG}$ (Note 4, 5) $V_{DS} = 400~V, I_{D} = 1.4~A, \label{eq:VGS}$ (Note 4, 5) $V_{GS} = 10~V \label{eq:VGS}$ (Note 4, 5)		25 8 20 4.0 1.1	60 25 50 5.5 	ns ns ns nC
$egin{array}{l} t_{d(on)} \\ t_r \\ t_{d(off)} \\ t_f \\ Q_g \\ Q_{gs} \\ Q_{gd} \\ \hline egin{array}{c} Drain-S \\ I_S \\ I_{SM} \\ \end{array}$	Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge Gate-Drain Charge	$R_G$ = 25 $\Omega$ (Note 4, 5) $V_{DS}$ = 400 V, $I_D$ = 1.4 A, $V_{GS}$ = 10 V (Note 4, 5)  and Maximum Ratings  ode Forward Current  Forward Current	   	25 8 20 4.0 1.1 2.2	60 25 50 5.5 	ns ns ns nC nC
$egin{array}{l} t_{d(on)} \\ t_r \\ t_{d(off)} \\ t_f \\ Q_g \\ Q_{gs} \\ Q_{gd} \\ \hline egin{array}{c} Drain-S \\ I_S \\ I_{SM} \\ \end{array}$	Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge Gate-Drain Charge  Source Diode Characteristics and Maximum Continuous Drain-Source Diode	$R_{G} = 25 \ \Omega$ $V_{DS} = 400 \ V, I_{D} = 1.4 \ A,$ $V_{GS} = 10 \ V$ $(Note 4, 5)$ $Note 5$ $Note 6$ $Note 6$ $Note 6$ $Note 6$ $Note 7$ $Note 7$ $Note 8$ $Note 8$ $Note 8$ $Note 9$ $Note $		25 8 20 4.0 1.1 2.2	60 25 50 5.5 	ns ns ns nC nC
$egin{array}{l} t_{d(on)} \\ t_{r} \\ t_{d(off)} \\ t_{f} \\ Q_{g} \\ Q_{gs} \\ Q_{gd} \\ \hline egin{array}{c} Drain-S \\ I_{S} \\ \hline \end{array}$	Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge Gate-Drain Charge  Source Diode Characteristics and Maximum Continuous Drain-Source Diode Fall Time	$R_G$ = 25 $\Omega$ (Note 4, 5) $V_{DS}$ = 400 V, $I_D$ = 1.4 A, $V_{GS}$ = 10 V (Note 4, 5)  and Maximum Ratings  ode Forward Current  Forward Current	   	25 8 20 4.0 1.1 2.2	60 25 50 5.5   1.1 4.4	ns ns ns nC nC

- **Notes:**1. Repetitive Rating : Pulse width limited by maximum junction temperature 2. L = 120mH, I<sub>AS</sub> = 1.1A, V<sub>DD</sub> = 50V, R<sub>G</sub> = 25 Ω, Starting T<sub>J</sub> = 25°C 3. I<sub>SD</sub> ≤ 1.4A, di/dt ≤ 200A/μs, V<sub>DD</sub> ≤ BV<sub>DSS</sub>, Starting T<sub>J</sub> = 25°C 4. Pulse Test : Pulse width ≤ 300μs, Duty cycle ≤ 2% 5. Essentially independent of operating temperature

# **Typical Characteristics**

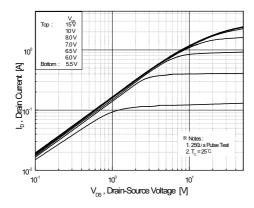


Figure 1. On-Region Characteristics

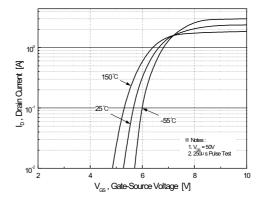


Figure 2. Transfer Characteristics

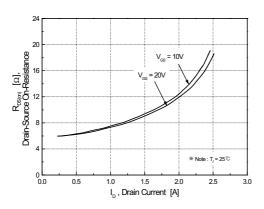


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

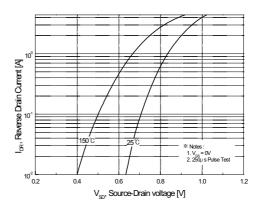


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

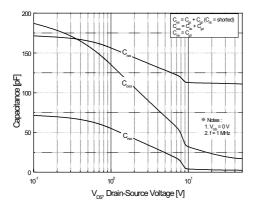


Figure 5. Capacitance Characteristics

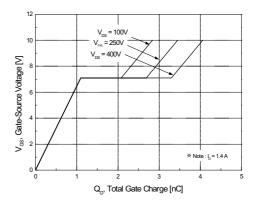


Figure 6. Gate Charge Characteristics

## Typical Characteristics (Continued)

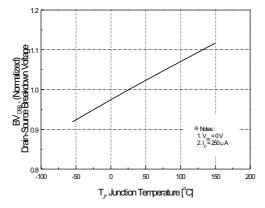


Figure 7. Breakdown Voltage Variation vs. Temperature

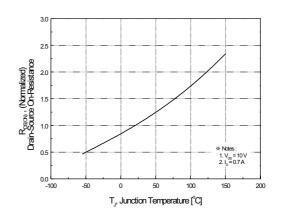


Figure 8. On-Resistance Variation vs. Temperature

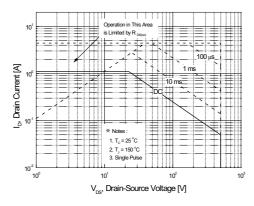


Figure 9. Maximum Safe Operating Area

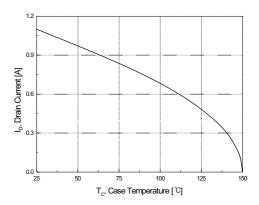


Figure 10. Maximum Drain Current vs. Case Temperature

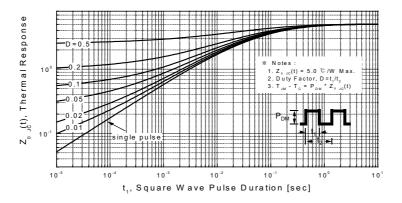
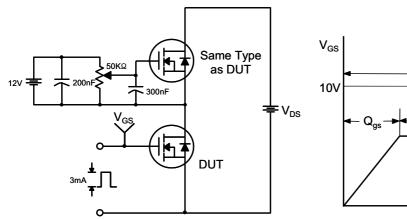
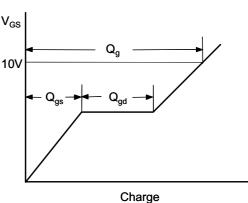


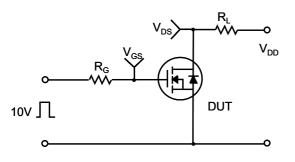
Figure 11. Transient Thermal Response Curve

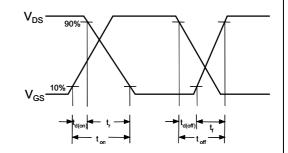
### **Gate Charge Test Circuit & Waveform**



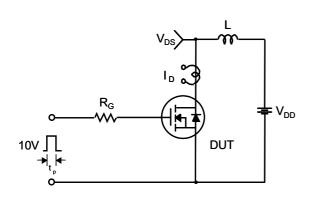


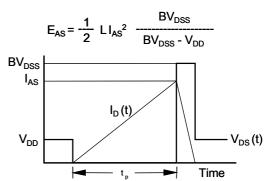
### **Resistive Switching Test Circuit & Waveforms**



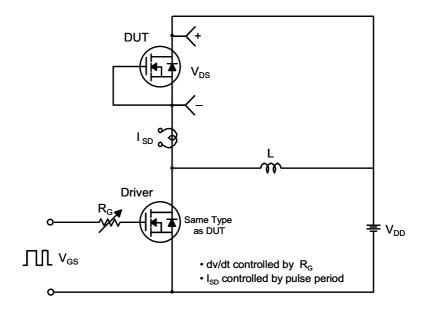


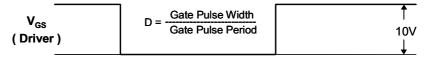
### **Unclamped Inductive Switching Test Circuit & Waveforms**

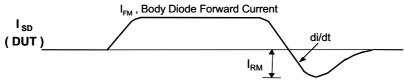




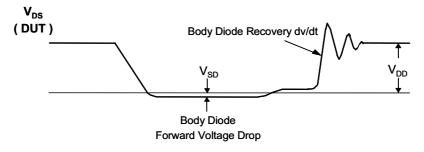
#### Peak Diode Recovery dv/dt Test Circuit & Waveforms







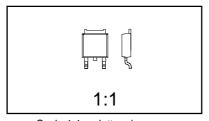
**Body Diode Reverse Current** 



### **Package Dimensions**

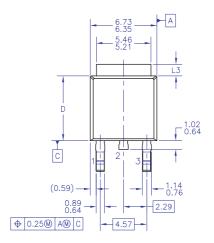
# TO-252 (DPAK) (FS PKG Code 36)

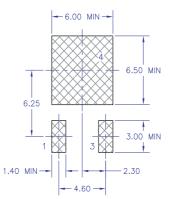




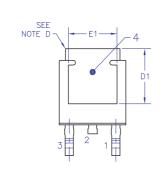
Scale 1:1 on letter size paper Dimensions shown below are in: millimeters

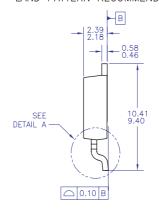
Part Weight per unit (gram): 0.33

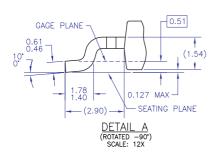




LAND PATTERN RECOMMENDATION







- NOTES: UNLESS OTHERWISE SPECIFIED

  A) ALL DIMENSIONS ARE IN MILLIMETERS.

  B) THIS PACKAGE CONFORMS TO JEDEC, TO-252, ISSUE C, VARIATION AA & AB, DATED NOV. 1999.

  C) DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994.

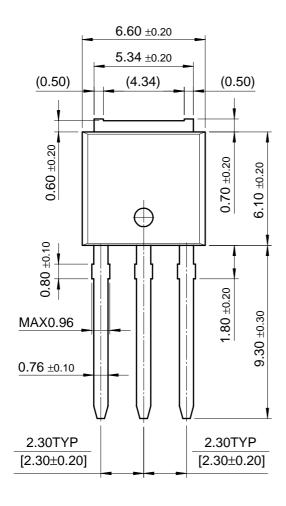
  D) HEAT SINK TOP EDGE COULD BE IN CHAMFERED CORNERS OR EDGE PROTRUSION.

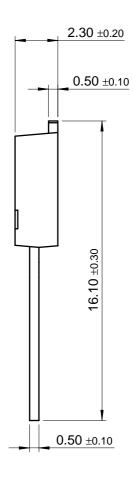
  E) DIMENSIONS L3,D,E1&D1 TABLE:

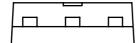
	OPTION AA	OPTION AB
L3	0.89-1.27	1.52-2.03
D	5.97-6.22	5.33-5.59
E1	4.32 MIN	3.81 MIN
D1	5.21 MIN	4.57 MIN



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Datasheet Identification	Product Status	Definition
Advance Information	Formative / In Design	Datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
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